

# MAPAN-Journal of Metrology Society of India

## CALL FOR PAPERS

The *MAPAN-Journal of Metrology Society of India*, a leading SCI indexed quarterly publication, exclusively devoted to Metrology (Scientific, Industrial or Legal), is being published by Metrology Society of India in collaboration with Springer Nature India Pvt. Ltd.; National Physical Laboratory (NPLI) and Council of Scientific and Industrial Research (CSIR), New Delhi, India. In the past, several theme-based special issues have been published in the journal on various aspects of metrology by eminent metrologists as **Guest Editors**. In continuation of such efforts, the journal has decided to publish another special issue on the following topic:

### **Special Issue Topic: Redefinition of SI Units and its Implications**

**Scheduled for Publication:** August 2020

The journal invites the submission of research communications or technical articles or review articles on topics of current interest. Original work, tutorials and survey papers, which contribute to new knowledge or understanding of any metrology principle, method or technique, are welcome. Papers are considered for publication on the clear understanding that they have not been published previously or submitted to another journal for publication.

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- A cover sheet containing a short title, names, affiliations and addresses of all authors.
- The manuscript must start from the next page with the title on top of the page.
- An abstract of about 100-200 words should be provided on the title page. The abstract should be understandable without reference to the article and should indicate the scope of the contribution, including the main conclusions.
- An introduction, which may begin with what is new in the paper, not with statements that are well known to everyone.
- Appropriate section of the text.
- A conclusion.
- An acknowledgement (optional).
- A list of references in a relevant format described in the next section.
- A set of original figures and tables.
- A list of captions for all figures and title for all tables.

## References

References must be prepared in proper format (examples of various types are given below) and numbered consecutively in the order in which they are cited in the text.

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